

Enhanced 900 A 1700 V ED Module with Micropattern Trench IGBT for High Performance and Reliability

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- ED type modules are a staple of the power electronics industry
- Widely used in industrial drives, renewable energy and automotive applications
- Highly scaled and standard footprint -> large focus on economical value

Main design focus:

- Provide best possible \$/A performance
- Rugged, low loss chipset
- Suitable for a wide variety of applications



Module design

Summary

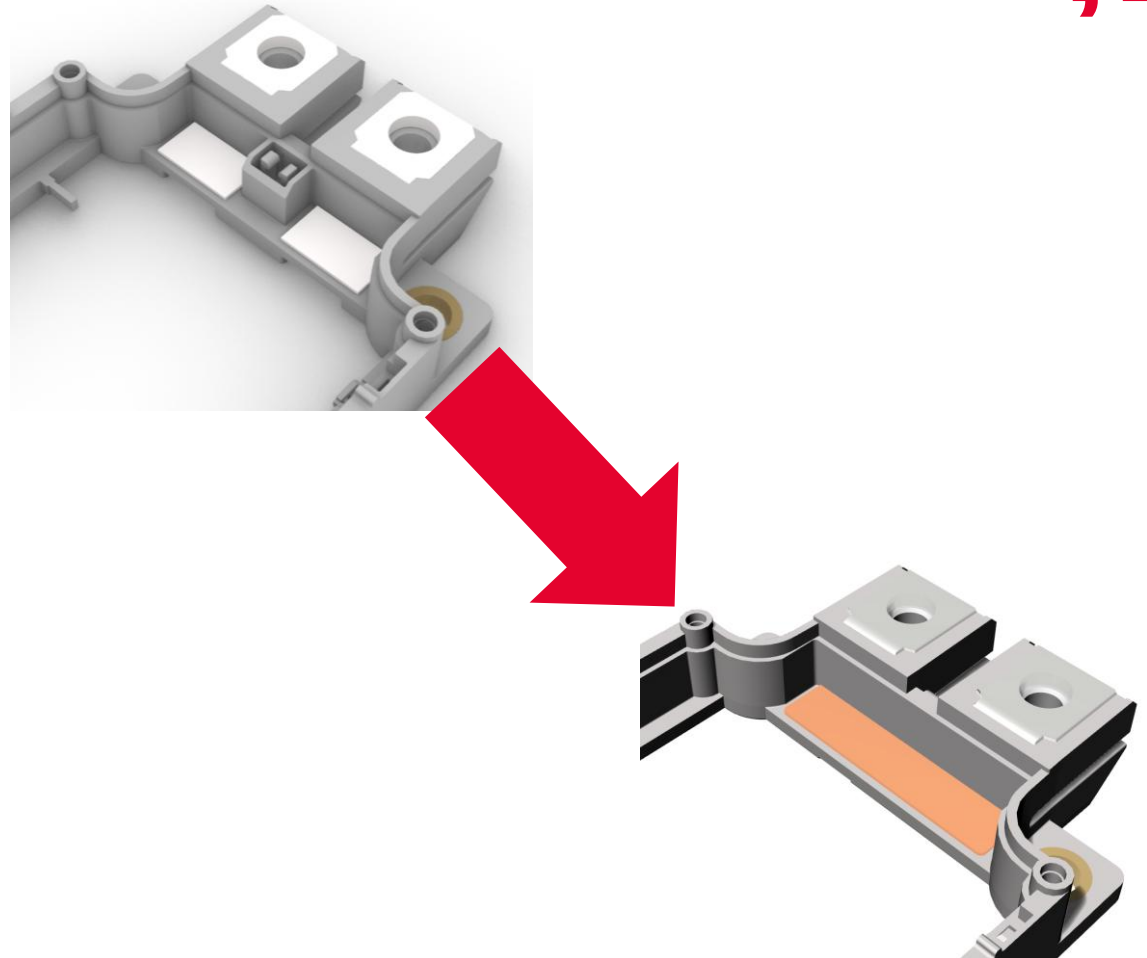
Main focus: improve module while reducing cost

- Improve current carrying capability
- Enhance power & thermal cycling reliability
- Reduce coupling on the IGBT for improved switching
- Enable more chip area for higher power density

Module design

Improved current carrying capability

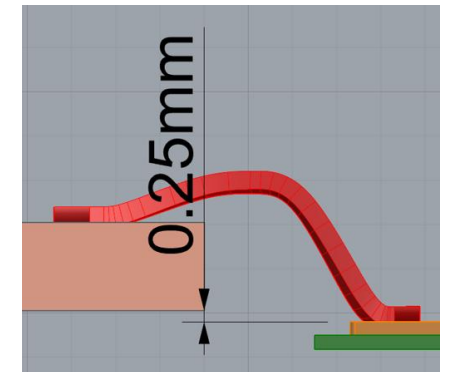
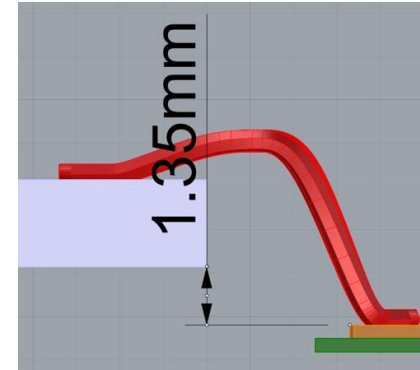
- Optimized power terminals for more bondable area
- Bare copper metallization for more stable bonding



Module design

Improved current carrying capability

- Optimized power terminals for more bondable area
- Bare copper metallization for more stable bonding
- 20mil copper wires & shorter loops on the terminals

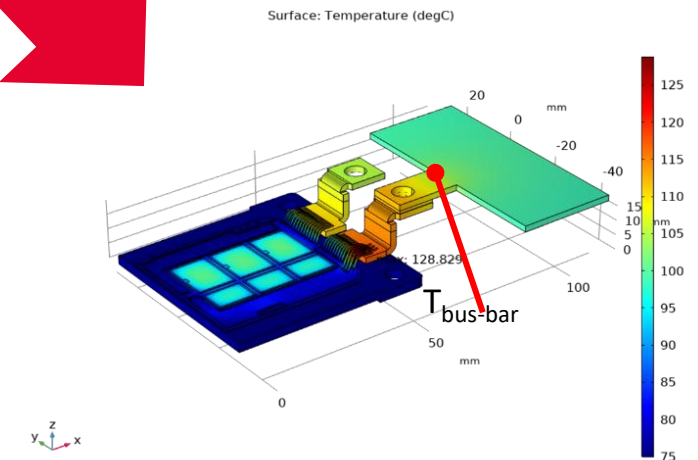
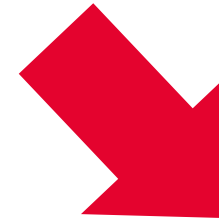
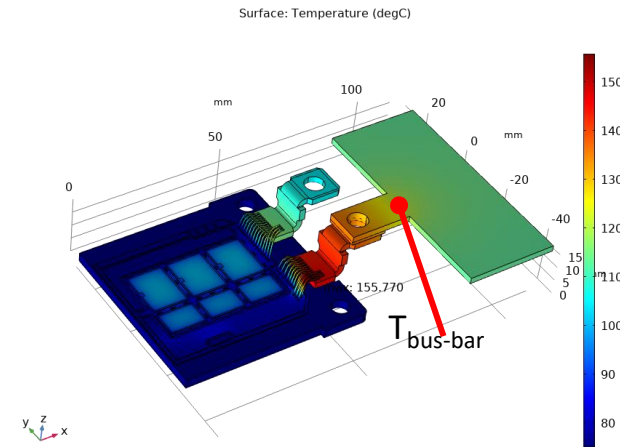


Module design

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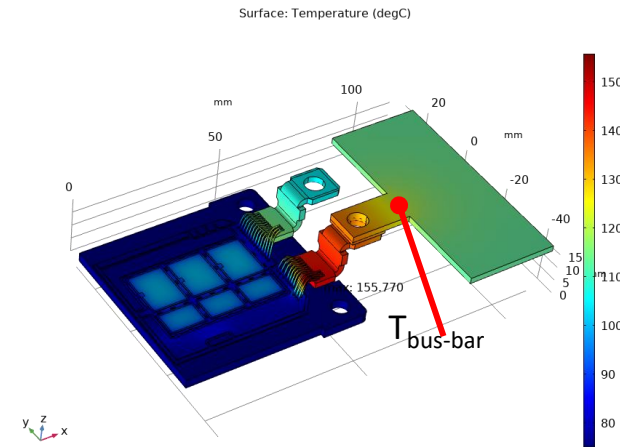
➔ The improvements lead to an average reduction in terminal temperature of more than 30 %



Module design

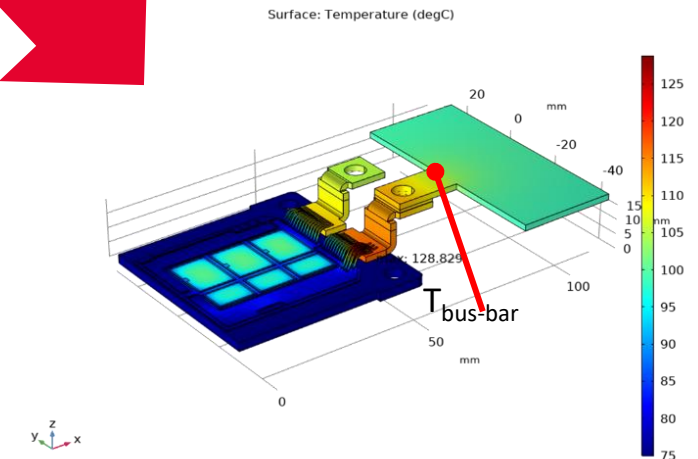
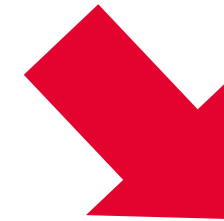
Improved current carrying capability

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➔ The improvements lead to an average reduction in terminal temperature of more than 30 %

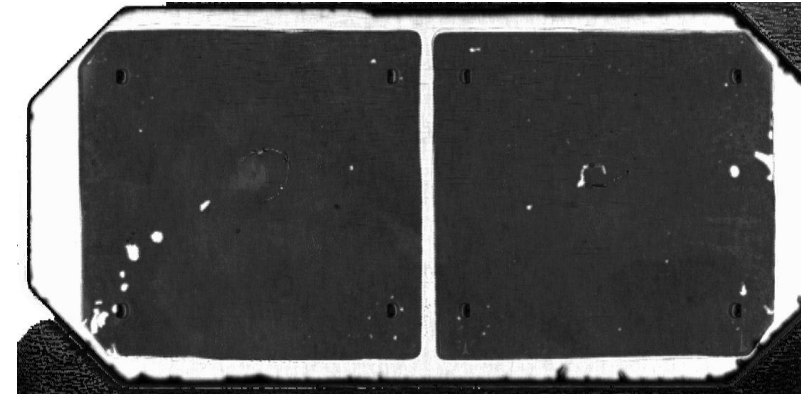
Terminal type	750 A Design (K)	900 A Design (K)	Delta (K)	Delta (%)
DC+	72.2	50.9	21.3	29.5
DC-	82.4	52.9	29.5	35.8
AC	61	44	17	27.9



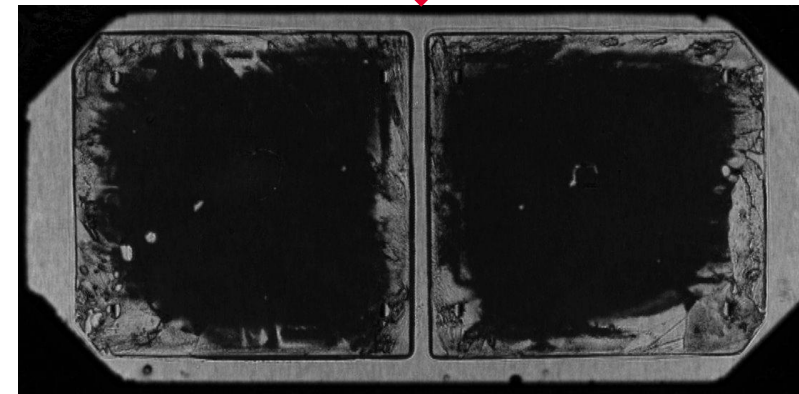
Module design

Enhanced thermal cycling reliability

- The soldering is improved for both the die attach and the substrate to baseplate
- A novel solder material is used to greatly increase the reliability of the solder joints



Previous solder after 1k cycles

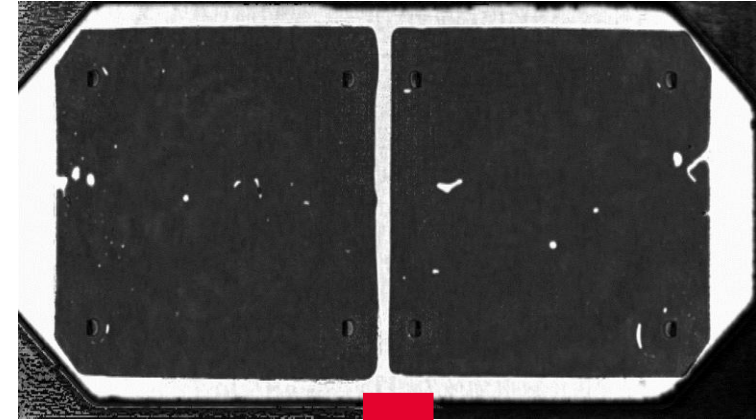


Module design

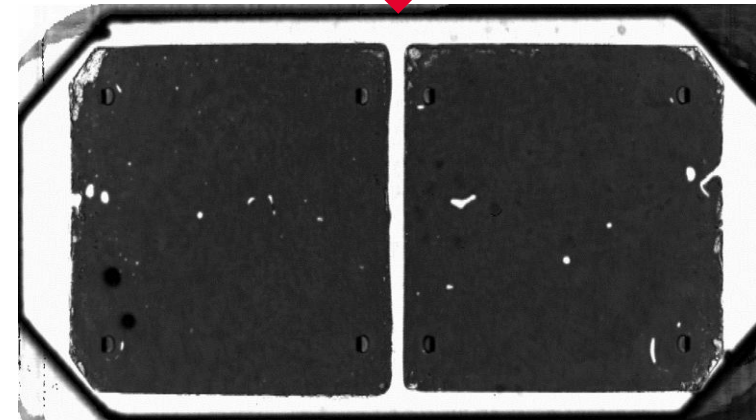
Enhanced thermal cycling reliability

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$T_{\min} = -40\text{ }^{\circ}\text{C}$, $T_{\max} = 125\text{ }^{\circ}\text{C}$, $t_{\text{change}} = 3\text{ s}$, $t_{\text{hold}} = 30\text{ min}$



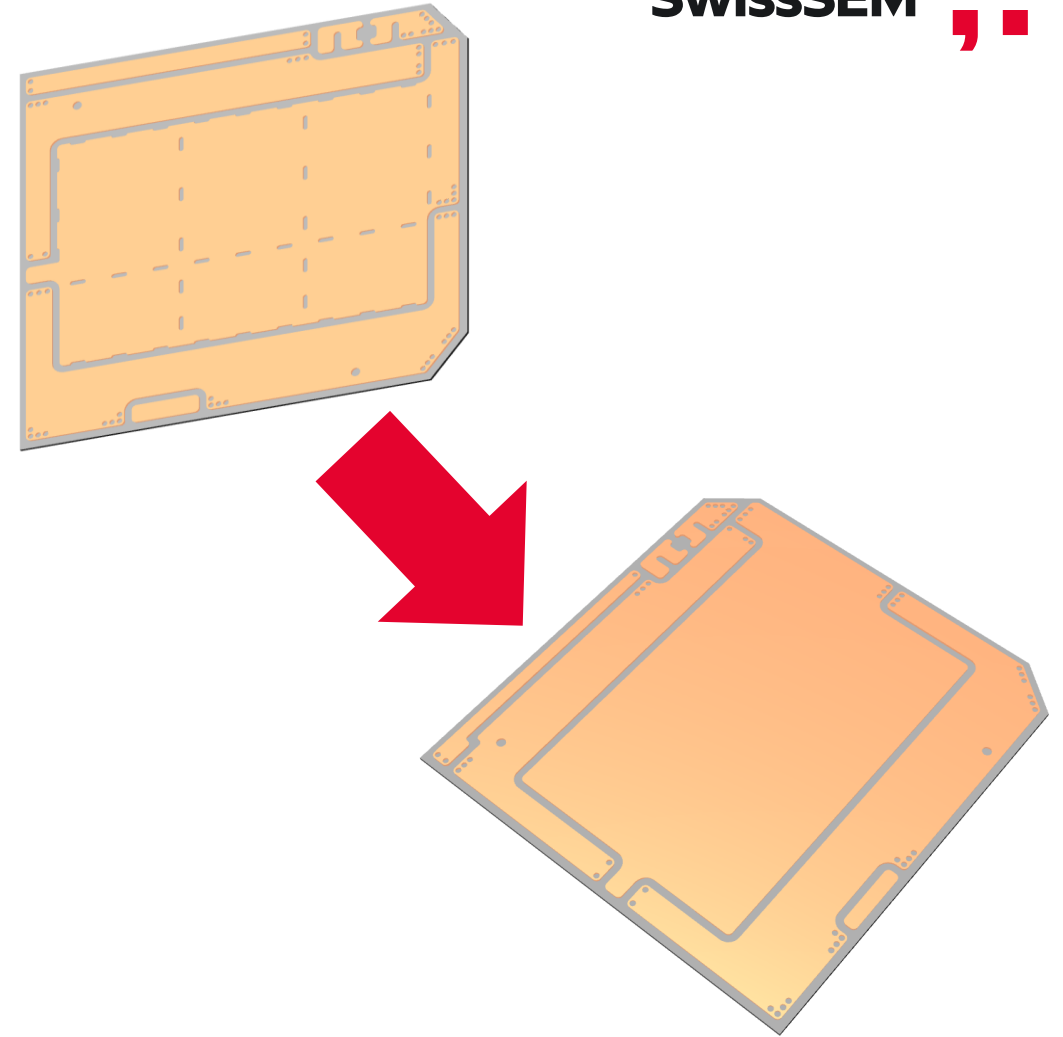
Improved solder after 1k cycles



Module design

Improved DBC substrate layout

- More chip area, more flexible chip placement

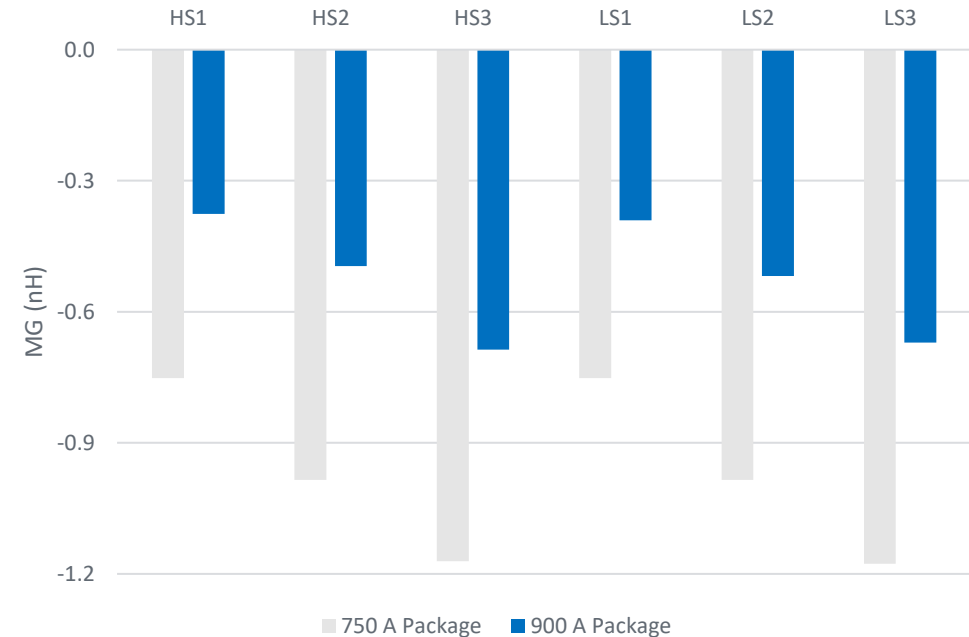


Module design

Improved DBC substrate layout

- More chip area, more flexible chip placement
- Reduced GE coupling for improved switching behavior

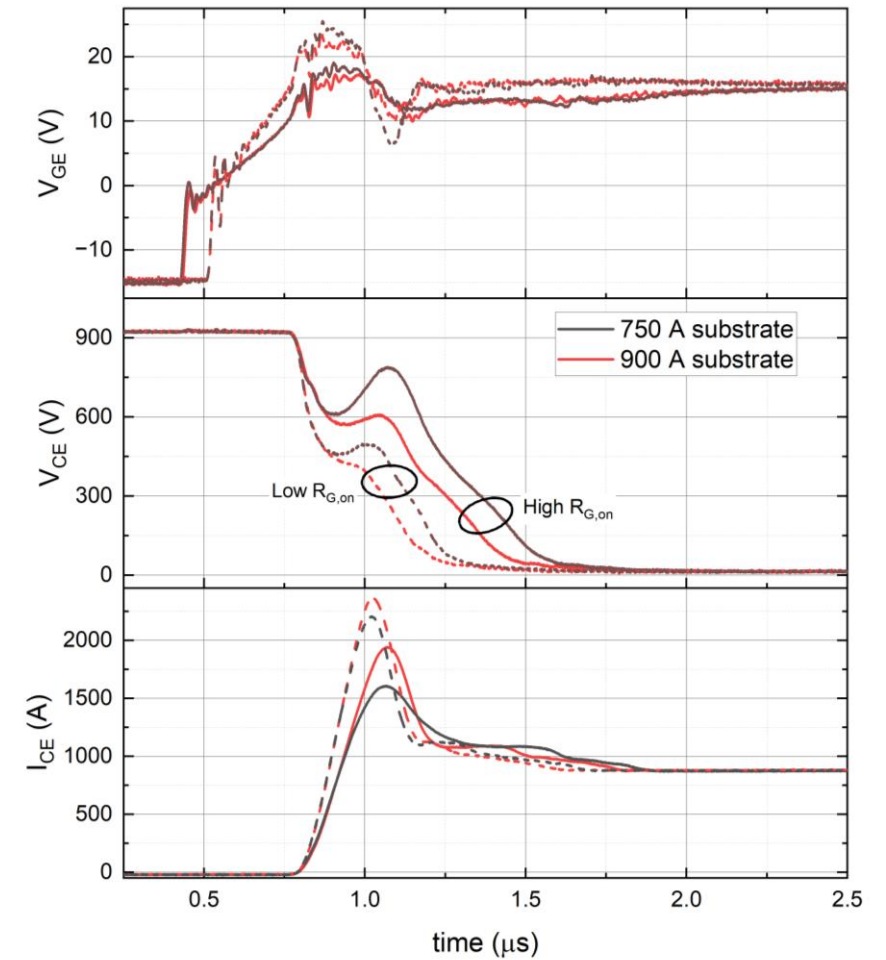
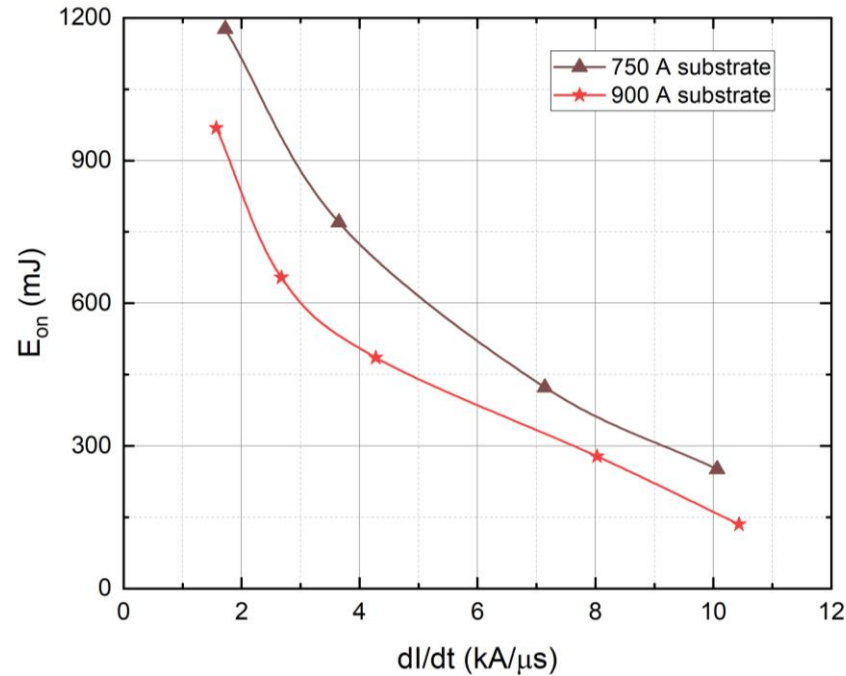
➔ GE coupling is reduced by 30 – 50 %



Module design

Improved DBC substrate layout

- More chip area, more flexible chip placement
- Reduced GE coupling for improved switching behavior
- Faster switching, reduced E_{on}



IGBT cell design

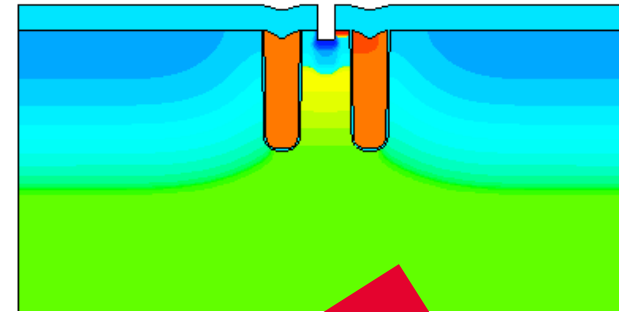
LC³ IGBT

IGBT cell improvement drivers:

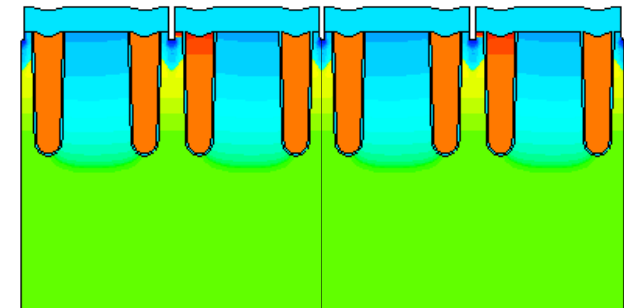
- Higher cell density by feature size shrinking
- Optimized arrangement of gate and emitter trenches
- Carrier confinement

Conduction and switching losses can be improved, but we need to consider:

- Turn-off controllability (Peak voltage at turn-off)
 - Reverse bias safe operating area (RBSOA)
 - Short-circuit safe operating area (SCSOA)
-
- ➔ Micropattern trench IGBT with LC³-concept allows further improvement on the technology curve while keeping controllability



Cell and trench pitch scaling
Asymmetric P+ diffusion



Diode design

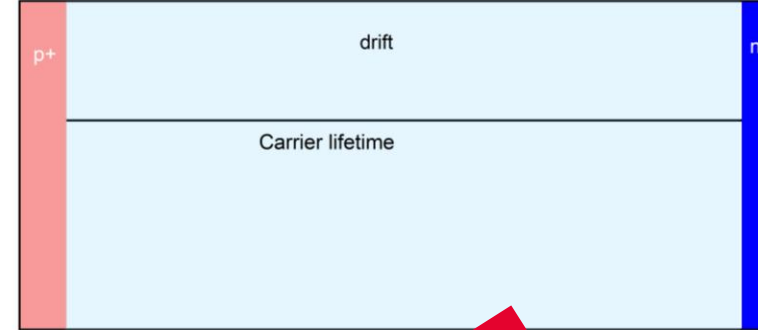
QLLC Diode

Diode improvement drivers:

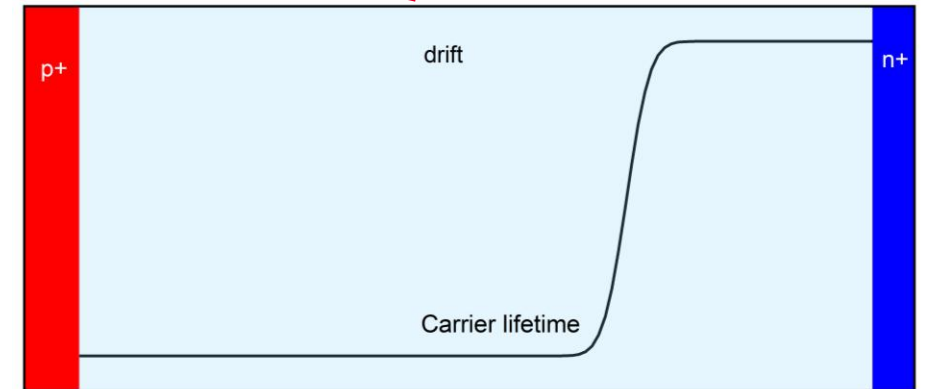
- Anode injection tuning
- Carrier lifetime control
- Drift region thickness

Conduction and switching losses can be improved, but we need to consider:

- Soft recovery behavior
- Diode safe operating area (DSOA)
- Temperature coefficient
- ➔ Diode with novel QLLC technology allows for increased emitter dose and thinner drift region while keeping the soft recovery behavior



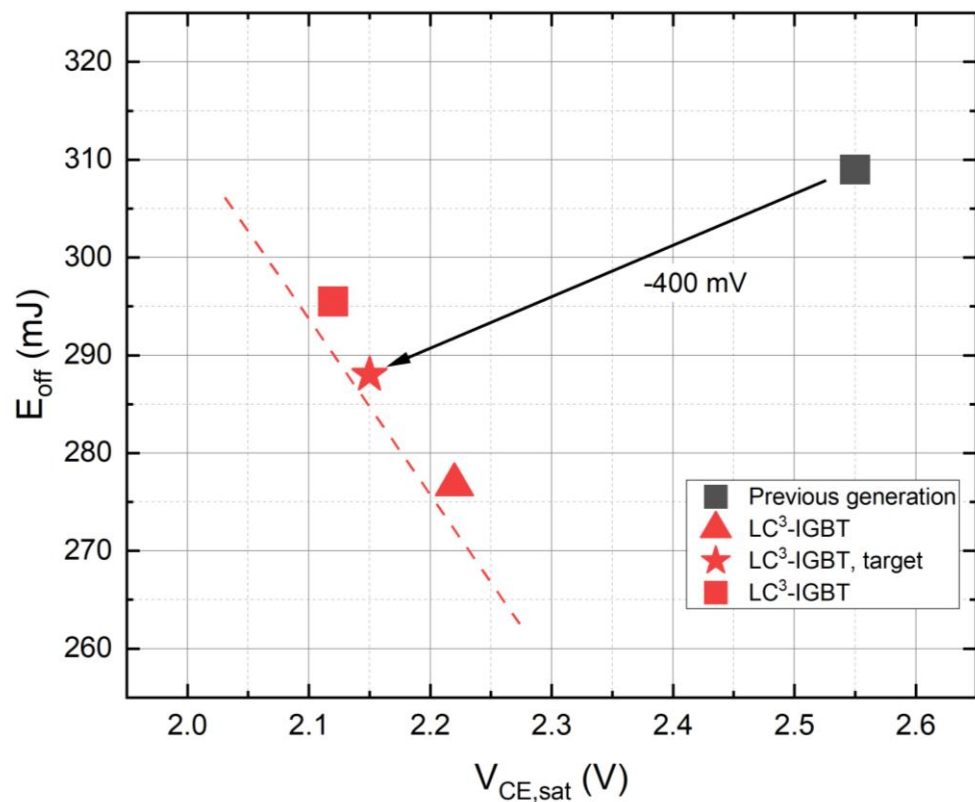
Higher anode efficiency
and carrier lifetime control



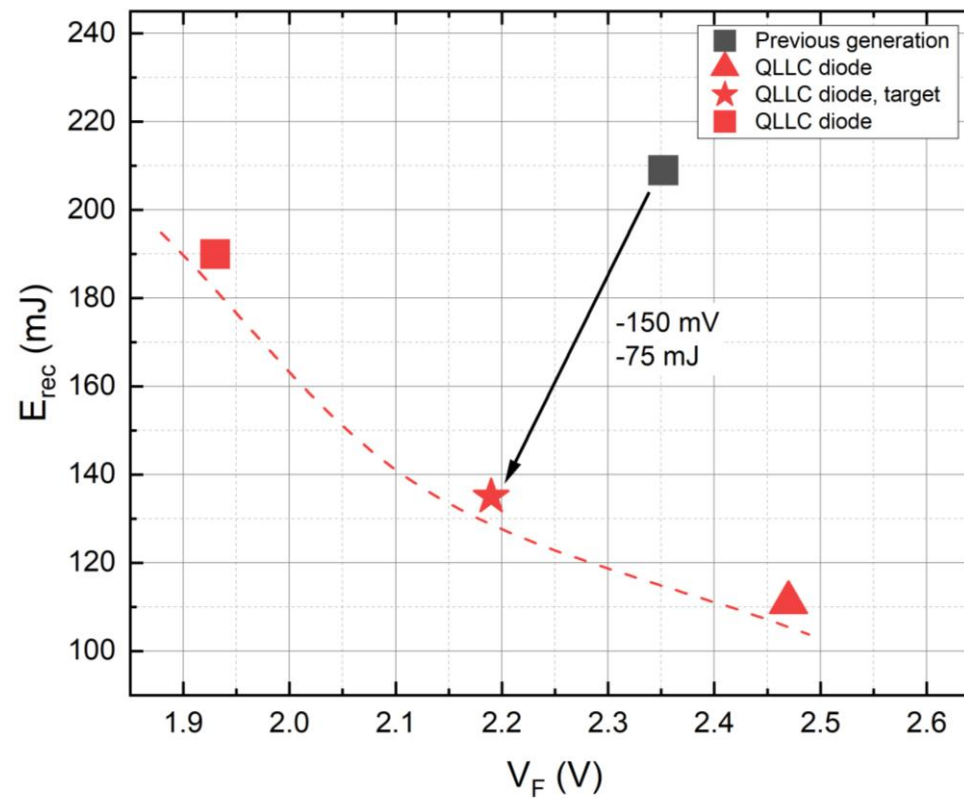
Technology curve

900 A, 900 V, $L_G = 35$ nH, 175 °C

Technology curve IGBT ($R_{G,off} = 0.5 \Omega$)



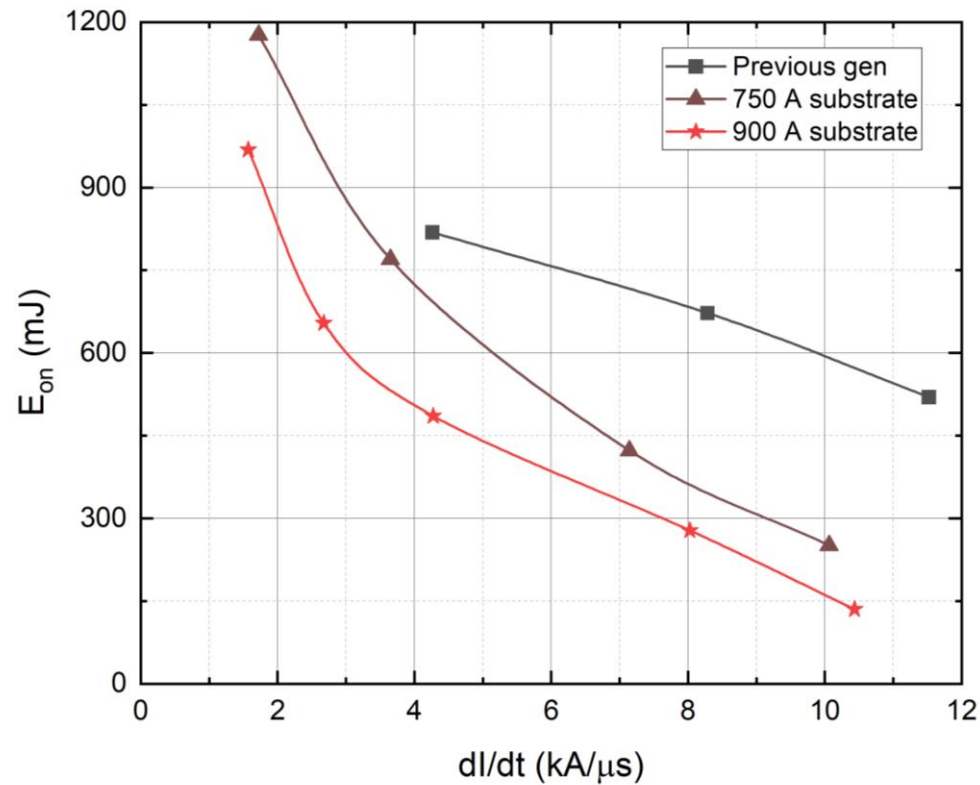
Technology curve Diode ($di/dt = 9$ kA/ μ s)



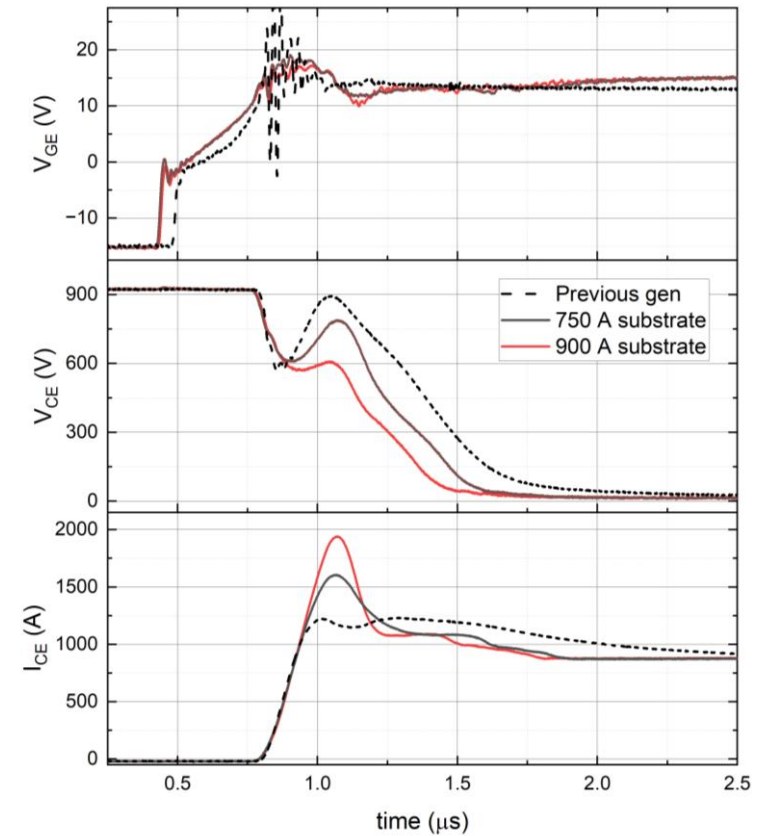
IGBT turn-on

900 A, 900 V, $L_G = 35$ nH, 175 °C

Turn-on energy vs di/dt



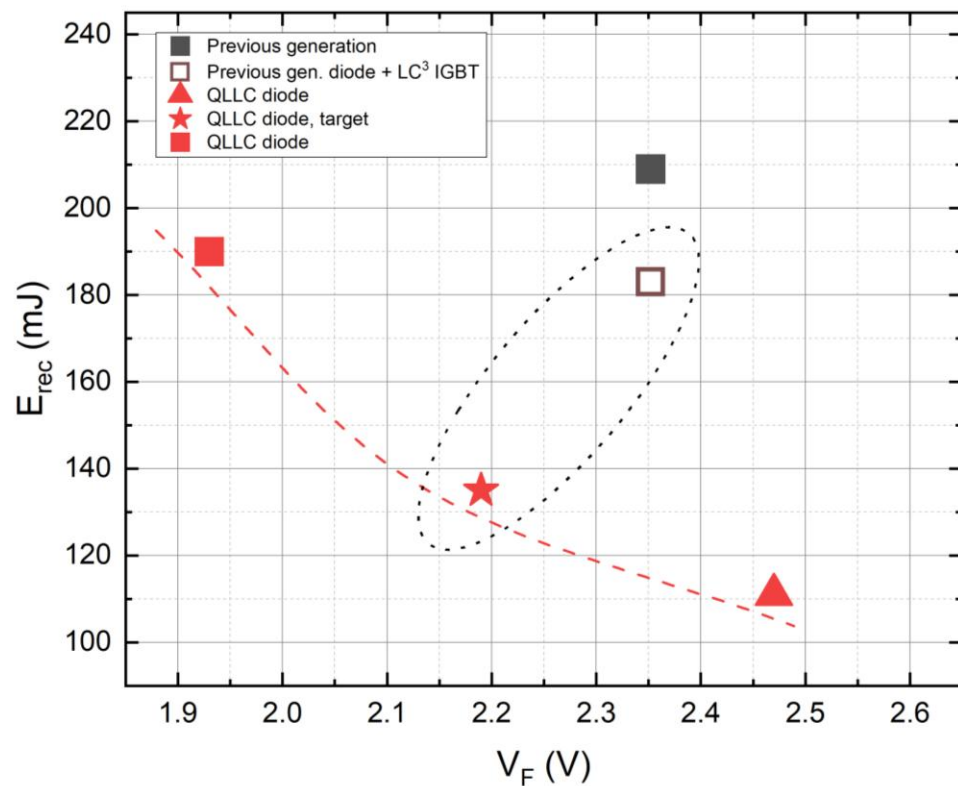
Turn-on waveform ($R_{G,on} = 0.5 \Omega, 1.5 \Omega$ for previous gen)



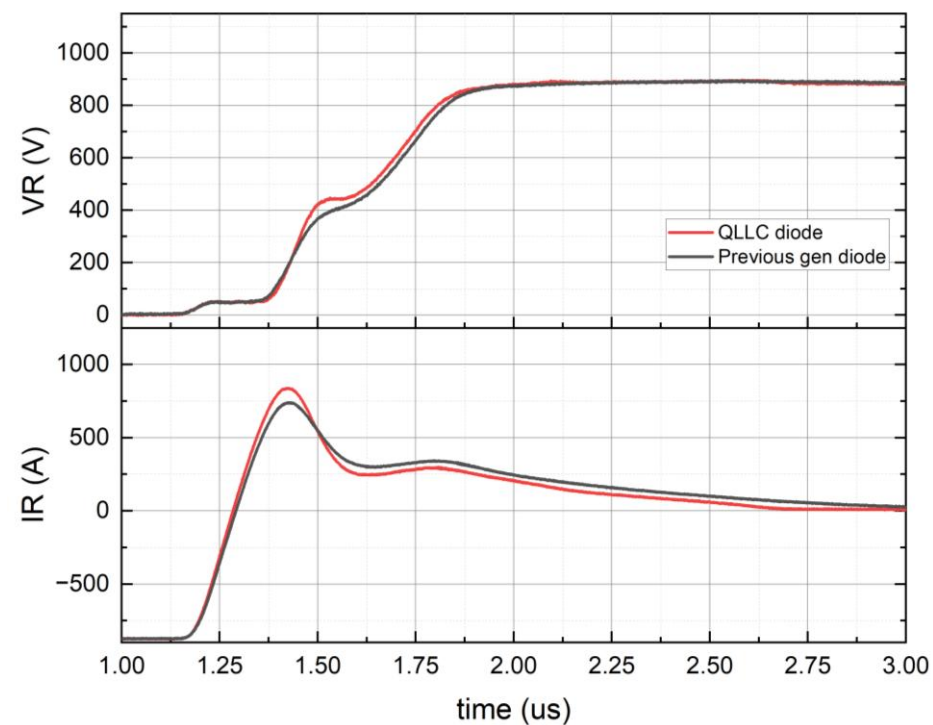
Diode recovery

900 A, 900 V, $R_{G,on} = 0.5 \Omega$, $L_\sigma = 35 \text{ nH}$, 175°C

Technology curve diode (both diodes with new IGBT)



Recovery waveform ($R_{G,on} = 0.5 \Omega$)

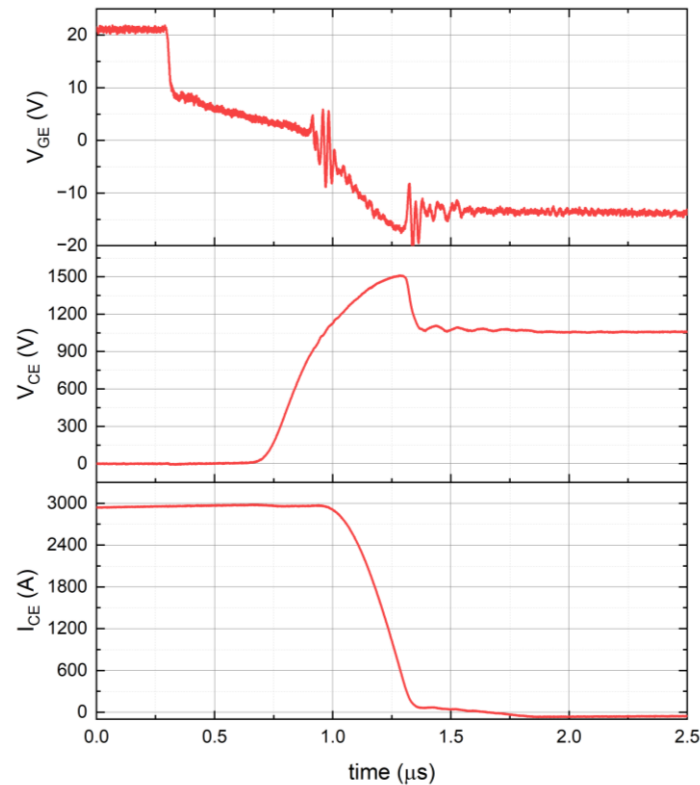


Safe operating area

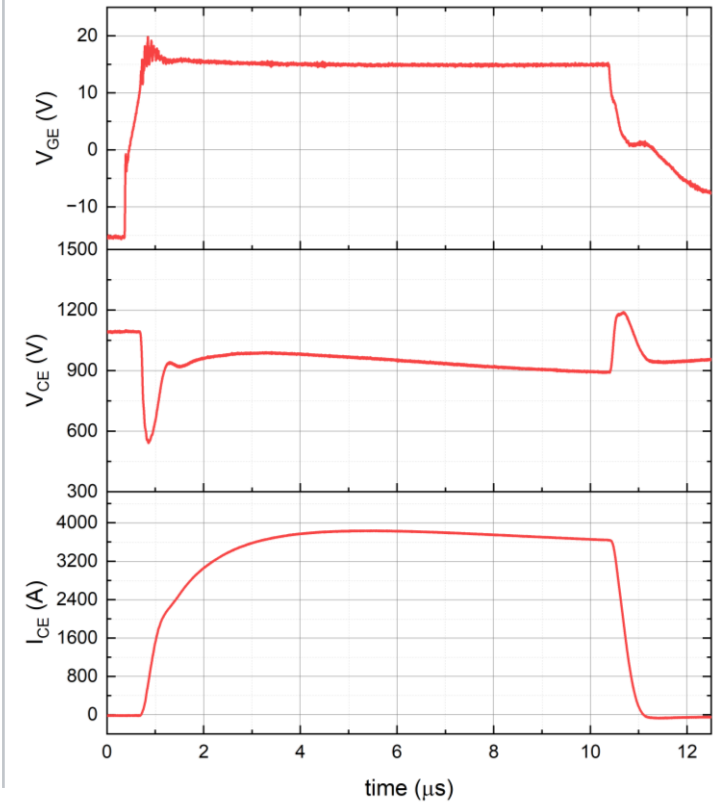
RBSOA / SCSOA $L_g = 35 \text{ nH}$, $175 \text{ }^\circ\text{C}$

- The novel LC³ IGBT is extremely robust in both RBSOA and SCSOA
- Large margin in SOA improves yield and reduces risk of failures in the field

RBSOA, 1100 V, 3000 A



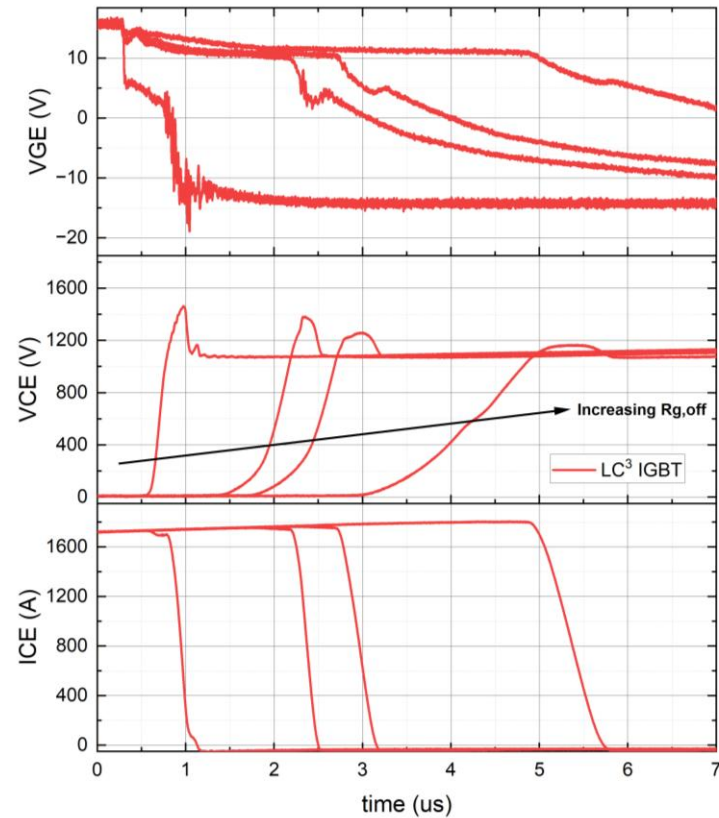
SCSOA, 1100 V, 10 μs



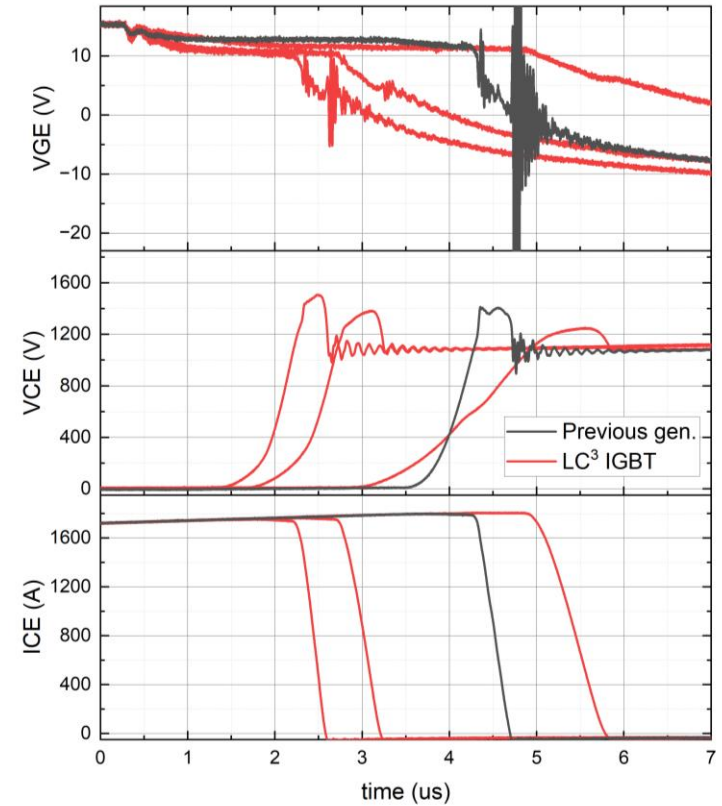
Turn-off controllability waveforms

$I_{CE} = 1800 \text{ A}$, $V_{CC} = 1100 \text{ V}$, $R_{G,off} = 0.5 \dots 40 \Omega$, 25°C

$L_o = 35 \text{ nH}$



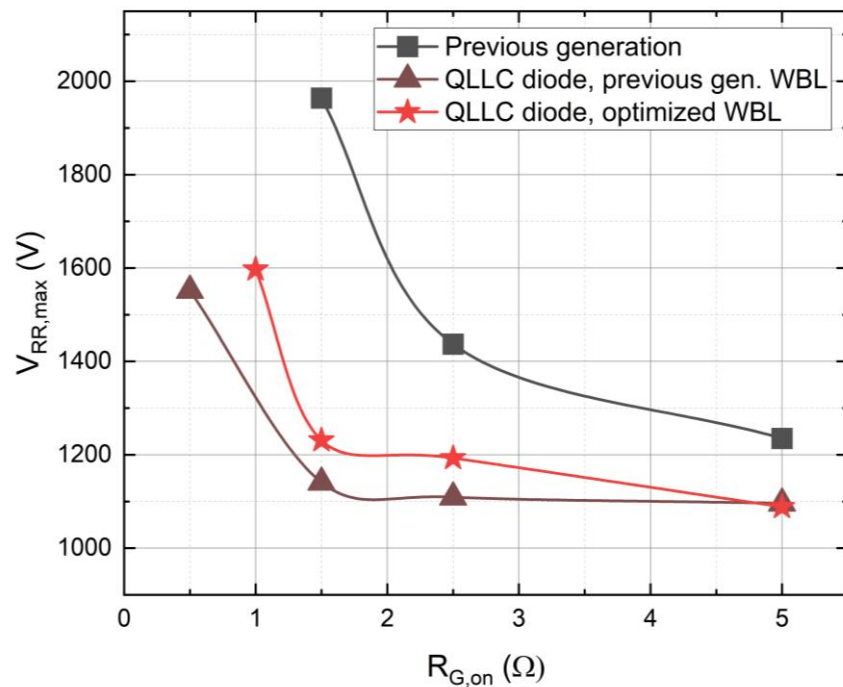
$L_o = 95 \text{ nH}$



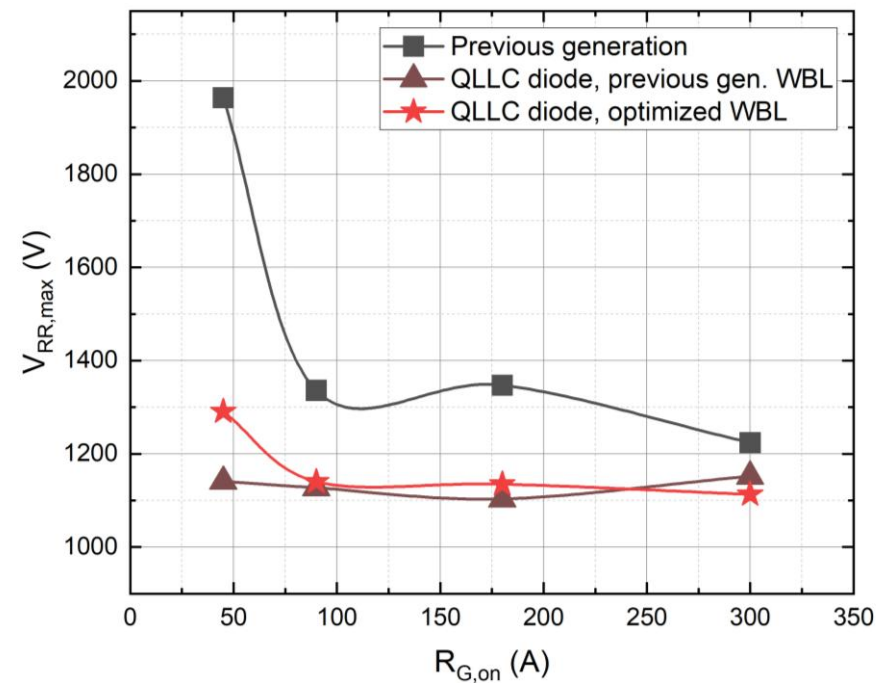
Diode softness

1100 V, $I_F = 45\text{ A}$, $L_\sigma = 95\text{ nH}$, $25\text{ }^\circ\text{C}$

Peak recovery voltage vs $R_{G,on}$

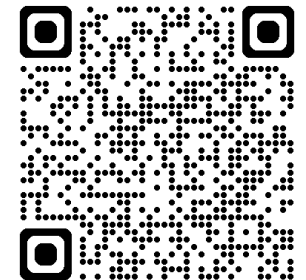


Diode softness waveforms, $I_F = 45\text{ A}$, $R_{G,on} = 1.5\text{ }\Omega$



→ Improved diode shows significantly improved softness and lower losses at the same time

- Summary:
 - The enhanced 900 A ED packaging from SwissSEM Technologies has been introduced
 - The new module features improved power terminal design, optimized bond-wire layout and DBC design, as well as a more reliable solder material
 - A new 1.7 kV 900 A chipset has been developed and the results shown
- Conclusion:
 - The new SwissSEM 900 A ED module features higher current carrying capability, better thermal cycling performance and enables faster switching
 - The novel chipset features class leading losses and SOA ruggedness
 - Inquire at our booth (N5 C01) for sample availability
 - Check our website for detailed product information: <https://www.swiss-sem.com/product-catalogue>



mesago

pcim

6 – 8.5.2025
NUREMBERG, GERMANY

**Thank you for
the attention!**

I'm pleased to answer your
questions.

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Messe Frankfurt Group